



High Power Thick Film Chip Resistors							
7. Performan	ce specification:						
Characteristics	Limits	Test Methods (JIS C 5201-1)					
Dielectric withstanding voltage	No evidence of flashover mechanical damage, arcing or insulation break down	4.7 Clamped in the trough of a 90°C metallic v-block and shall be tested at ac potential respectively specified in the type for 60-70 seconds					
Temperature Coefficient	1Ω~10Ω ≤± 200PPM/°C 11Ω~10MΩ ≤± 100PPM/°C	4.8 Natural resistance change per temp. degree centigrade. R2-R1 x 10 ⁶ (PPM/°C) R1(t2-t1) R1: Resistance value at room temperature (T1) R2: Resistance value at room temp. plus 100 °C(T2) Test pattern: room temp. (T1), room temp. +100°C(T2)					
Short time overload	Resistance change rate is \pm 5% (2.0% + 0.1 Ω) Max. \pm 1% (1.0% + 0.1 Ω) Max.	4.13 Permanent resistance change after the application of a potential of 2.5 times RCWV for 5 seconds					



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7. Performano	ce specification :			
Characteristics	Limits		Test Metho (JIS C 5201	
Solderability	95 % coverage Min.	245°C ±3°C Refolw: 250 200	ature of solder: C dipping time in sold AX VALUE TEMPERATURE: 245°C - 250°C	er: 2-3 seconds.
Soldering heat	Resistance change rate is: $\pm (1.0\%+0.05\Omega)$ Max.	_	e resistor into a solder re of 260°C±3°C and	_
			ance change after conduty cycle specified	
		Step	Temperature	Time
Temperature	Resistance change rate is	1	-55°C ± 3°C	30 mins
cycling	\pm 5% (1.0% + 0.05 Ω) Max.	2	Room temp.	10~15 mins
	$\pm 1\% \ (0.5\% + 0.05 \Omega) \ \text{Max}.$	3	+155°C ± 2°C	30 mins
		4	Room temp.	10~15 mins





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7. Performan	ce specification:						
Characteristics	Limits	Test Methods (JIS C 5201-1)					
Humidity	Resistance change rate is \pm 5% (3.0% + 0.1 Ω) Max. \pm 1% (0.5% + 0.1 Ω) Max.	4.24 Temporary resistance change after 240 hours exposure in a humidity test chamber controlled at 40±2°C and 90-95% relative humidity					
Load life in humidity	Resistance change rate is $\pm 5\% \ (3.0\% + 0.1 \Omega) \ \text{Max}.$ $\pm 1\% \ (1.0\% + 0.1 \Omega) \ \text{Max}.$	7.9 Resistance change after 1,000 hours (1.5 hours "on", 0.5 hour "off") at RCWV in a humidity chamber controlled at $40^{\circ}\text{C} \pm 2^{\circ}\text{C}$ and 90 to 95 % relative humidity					
Load Life	Resistance change rate is $\pm 5\% \ (3.0\% + 0.1 \Omega) \ \text{Max}.$ $\pm 1\% \ (1.0\% + 0.1 \Omega) \ \text{Max}.$	4.25.1 Permanent resistance change after 1,000 hours operating at RCWV, with duty cycle of (1.5 hours"on", 0.5 hour"off") at 70°C ± 2°C ambient					
Terminal bending	Resistance change rate is $\pm (1.0\% + 0.05\Omega)$ Max.	4.33 Twist of Test Board: Y/X = 3/90 mm for 60 seconds					

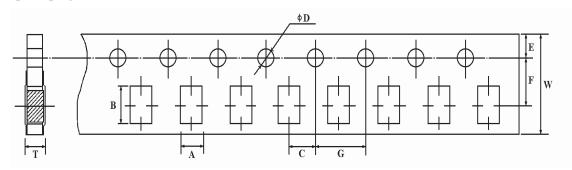


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8. Packing specification:

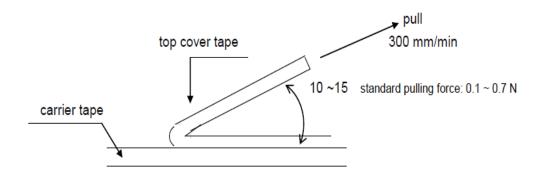
- 8.1 Taping Dimension (mm)
 - A. Paper taping



Туре	A ± 0.2	B ± 0.2	$C \pm 0.05$	φD+0.1	E ± 0.1	$F \pm 0.05$	$G \pm 0.1$	W ± 0.2	T ± 0.1
HP03	1.10	1.90	2.0	1.5	1.75	3.5	4.0	8.0	0.67
HP05	1.65	2.40	2.0	1.5	1.75	3.5	4.0	8.0	0.81
HP06	2.00	3.60	2.0	1.5	1.75	3.5	4.0	8.0	0.81

^{*} Peeling Strength of Top Cover Tape

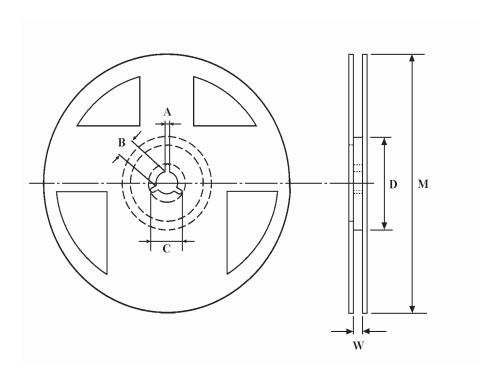
Test Condition: 0.1 to 0.7 N at a peel-off speed of 300 mm / min.



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8.2 Reel Dimension (mm)



Type	Packaging	Quantity Per Reel	$A \pm 0.5$	B ± 0.5	C ± 0.5	D ± 1	M ± 2	W ± 1
HP03	Paper	5,000 pcs.	2	13	21	60	178	10
HP05	Paper	5,000 pcs.	2	13	21	60	178	10
HP06	Paper	5,000 pcs.	2	13	21	60	178	10

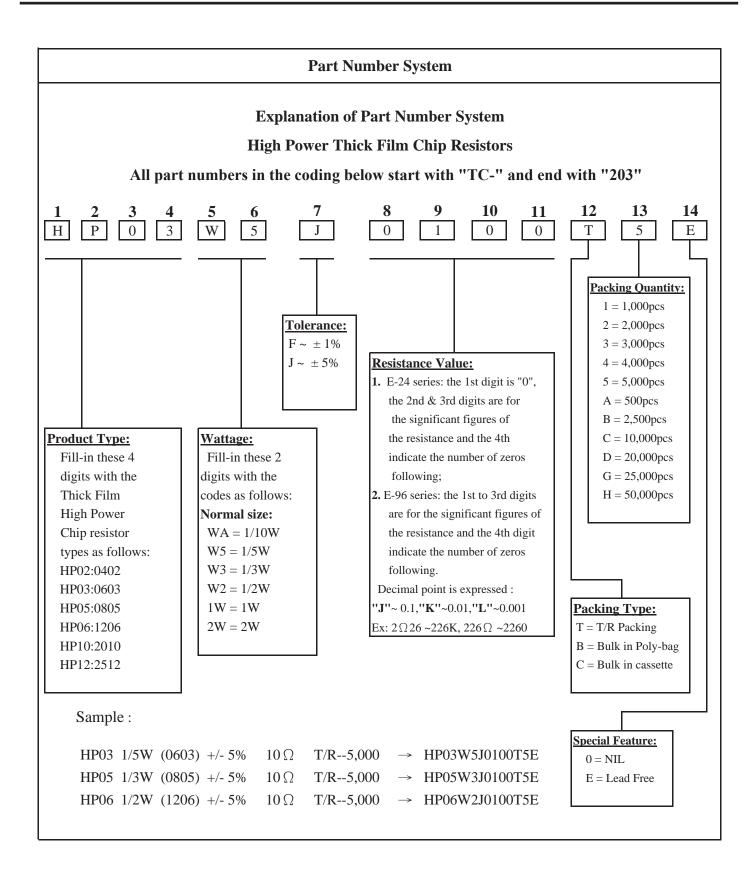
Remark : $\phi M 10,000 pcs. / Reel = 255 \pm 2mm$

20,000pcs. / Reel = 330 ± 2 mm



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Datasheet





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Environment Related Substance

This product complies to EU RoHS directive, EU PAHs directive, EU PFOS directive and Halogen free.

Ozone layer depleting substances.

Ozone depleting substances are not used in our manufacturing process of this product.

This product is not manufactured using Chloro fluorocarbons (CFCs), Hydrochlorofluorocarbons (HCFCs), Hydrobromofluorocarbons (HBFCs) or other ozone depleting substances in any phase of the manufacturing process.

Storage Condition

The performance of these products, including the solderability, is guaranteed for a year from the date of arrival at your company, provided that they remain packed as they were when delivered and stored at a temperature of $25^{\circ}\text{C} \pm 5^{\circ}\text{C}$ and a relative humidity of $60\%\text{RH} \pm 10\%\text{RH}$

Even within the above guarantee periods, do not store these products in the following conditions. Otherwise, their electrical performance and/or solderability may be deteriorated, and the packaging materials (e.g. taping materials) may be deformed or deteriorated, resulting in mounting failures.

- 1. In salty air or in air with a high concentration of corrosive gas, such as Cl₂, H₂S, NH₃, SO₂, or NO₂
- 2. In direct sunlight

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